# **Power MOSFET**

# 60 V, 11.5 mΩ, Single N-Channel, $\mu$ 8FL

#### **Features**

- Small Footprint (3.3x3.3 mm) for Compact Design
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- NVTFS5820NLWF Wettable Flanks Product
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

## MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Parar	Symbol	Value	Unit		
Drain-to-Source Voltag	V <sub>DSS</sub>	60	V		
Gate-to-Source Voltage	Gate-to-Source Voltage			±20	V
Continuous Drain Cur-		T <sub>mb</sub> = 25°C	I <sub>D</sub>	29	Α
rent $R_{\Psi J-mb}$ (Notes 1, 2, 3, 4)	Steady	T <sub>mb</sub> = 100°C		20	
Power Dissipation	State	T <sub>mb</sub> = 25°C	$P_{D}$	21	W
R <sub>ΨJ-mb</sub> (Notes 1, 2, 3)		$T_{mb} = 100^{\circ}C$		10	
Continuous Drain Cur-		T <sub>A</sub> = 25°C	I <sub>D</sub>	11	Α
rent R <sub>θJA</sub> (Notes 1 & 3, 4)	Steady	T <sub>A</sub> = 100°C		8.0	
Power Dissipation	State	T <sub>A</sub> = 25°C	$P_{D}$	3.2	W
R <sub>θJA</sub> (Notes 1, 3)		T <sub>A</sub> = 100°C		1.6	
Pulsed Drain Current	Pulsed Drain Current $T_A = 25^{\circ}C$ , $t_p = 10 \mu s$			247	Α
Current limited by packa (Note 4)	I <sub>DmaxPkg</sub>	70	Α		
Operating Junction and	T <sub>J</sub> , T <sub>stg</sub>	-55 to 175	°C		
Source Current (Body D	I <sub>S</sub>	17	Α		
Single Pulse Drain-to–Source Avalanche Energy (T <sub>J</sub> = 25°C, V <sub>DD</sub> = 50 V, V <sub>GS</sub> = 10 V, $I_{L(pk)}$ = 31 A, L = 0.1 mH, $R_G$ = 25 $\Omega$ )			E <sub>AS</sub>	48	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			T <sub>L</sub>	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

#### THERMAL RESISTANCE MAXIMUM RATINGS (Note 1)

Parameter	Symbol	Value	Unit
Junction-to-Mounting Board (top) - Steady State (Note 2, 3)	$R_{\Psi J-mb}$	7.3	°C/W
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	47	

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Psi  $(\Psi)$  is used as required per JESD51-12 for packages in which substantially less than 100% of the heat flows to single case surface.
- 3. Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.
- Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

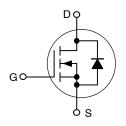


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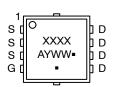
V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX
60 V	11.5 mΩ @ 10 V	29 A
	15 mΩ @ 4.5 V	297

# N-Channel



# Sales III

## WDFN8 (μ8FL) CASE 511AB



**MARKING DIAGRAM** 

XXXX = Specific Device Code
A = Assembly Location
Y = Year

WW = Work Week

= Pb-Free Package

(Note: Microdot may be in either location)

#### **ORDERING INFORMATION**

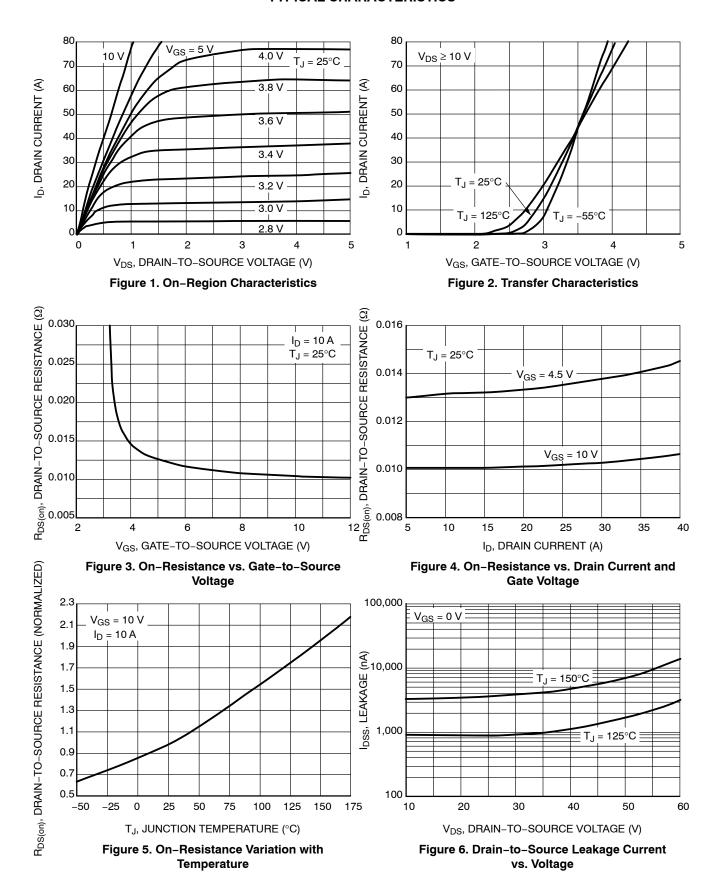
See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

# **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		60			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>				57		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C			1.0	μΑ
		$V_{DS} = 60 \text{ V}$	T <sub>J</sub> = 125°C			10	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub>	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 5)			•		•	•	
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D =$	250 μΑ	1.5		2.3	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>	33. 5			6.2		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 8.7 A		10.1	11.5	mΩ
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 7.3 A		13.0	15	
Forward Transconductance	g <sub>FS</sub>	V <sub>DS</sub> = 5 V, I <sub>D</sub> :	= 10 A		24.6		S
CHARGES, CAPACITANCES AND GA	ATE RESISTAN	ICE					
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0 V, f = 1.0 MHz, V <sub>DS</sub> = 25 V			1462		pF
Output Capacitance	C <sub>oss</sub>				150		
Reverse Transfer Capacitance	C <sub>rss</sub>				96		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 48	3 V, I <sub>D</sub> = 10 A		28		nC
		V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 4	8 V, I <sub>D</sub> = 10 A		15		1
Threshold Gate Charge	Q <sub>G(TH)</sub>				1		1
Gate-to-Source Charge	Q <sub>GS</sub>				4		1
Gate-to-Drain Charge	$Q_{GD}$	$V_{GS} = 4.5 \text{ V}, V_{DS} = 4.5 \text{ V}$	8 V, I <sub>D</sub> = 10 A		8		1
Plateau Voltage	V <sub>GP</sub>				3		V
Gate Resistance	$R_{G}$				0.62		Ω
SWITCHING CHARACTERISTICS (No	ote 6)						•
Turn-On Delay Time	t <sub>d(on)</sub>				10		ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub>	s = 48 V.		28		1
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D$ = 10 A, $R_G$ = 2.5 $\Omega$			19		1
Fall Time	t <sub>f</sub>				22		1
DRAIN-SOURCE DIODE CHARACTE	RISTICS						•
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 10 A	T <sub>J</sub> = 25°C		0.79	1.2	V
			T <sub>J</sub> = 125°C		0.65		
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0 \text{ V, } d_{1S}/d_t = 100 \text{ A}/\mu\text{s,}$ $I_S = 10 \text{ A}$			19		ns
Charge Time	t <sub>a</sub>				13		
Discharge Time	t <sub>b</sub>				6		
Reverse Recovery Charge	Q <sub>RR</sub>				15		nC

<sup>5.</sup> Pulse Test: pulse width  $\leq 300~\mu s$ , duty cycle  $\leq 2\%$ .
6. Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS**



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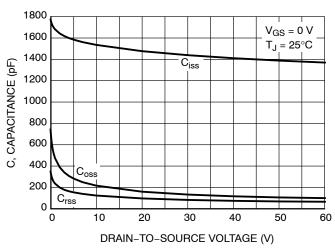


Figure 7. Capacitance Variation

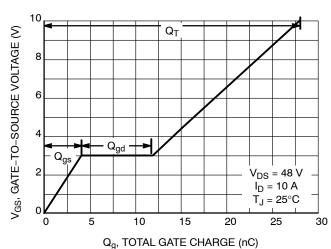


Figure 8. Gate-to-Source Voltage vs. Total Charge

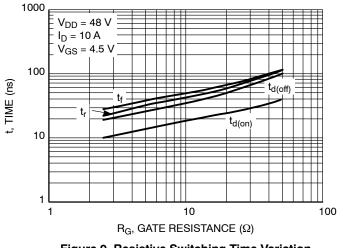


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

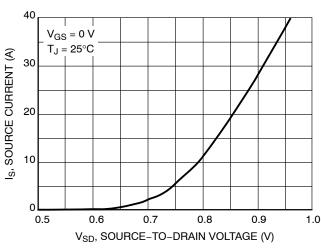


Figure 10. Diode Forward Voltage vs. Current

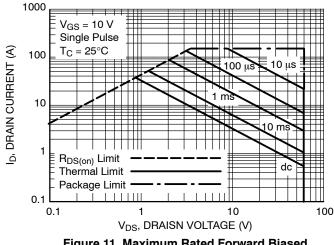


Figure 11. Maximum Rated Forward Biased Safe Operating Area

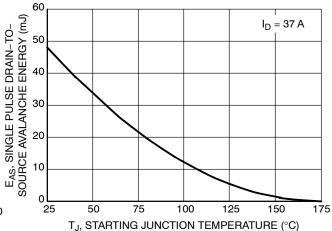


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

### **TYPICAL CHARACTERISTICS**

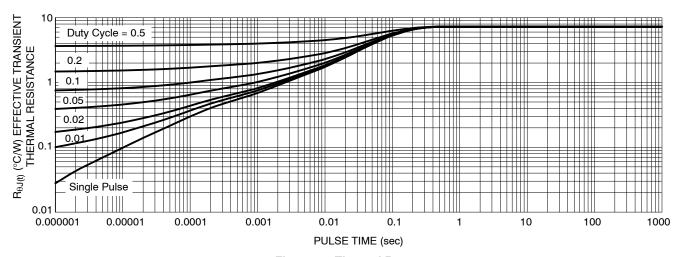


Figure 13. Thermal Response

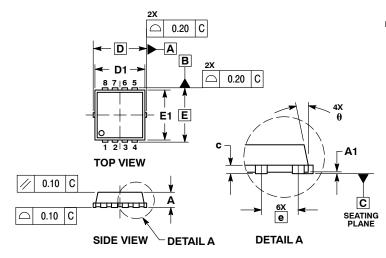
### **DEVICE ORDERING INFORMATION**

Device	Marking	Package	Shipping <sup>†</sup>
NVTFS5820NLTAG	5820	WDFN8 (Pb-Free)	1500 / Tape & Reel
NVTFS5820NLWFTAG	20LW	WDFN8 (Pb-Free)	1500 / Tape & Reel
NVTFS5820NLTWG	5820	WDFN8 (Pb-Free)	5000 / Tape & Reel
NVTFS5820NLWFTWG	20LW	WDFN8 (Pb-Free)	5000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### PACKAGE DIMENSIONS

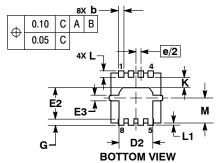
#### WDFN8 3.3x3.3, 0.65P CASE 511AB ISSUE D

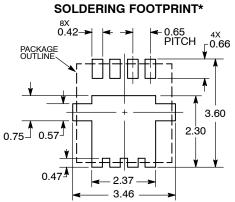


#### NOTES

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- CONTROLLING DIMENSION: MILLIMETERS.
  DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE BURRS.

	MILLIMETERS			INCHES			
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	0.70	0.75	0.80	0.028	0.030	0.031	
A1	0.00		0.05	0.000		0.002	
b	0.23	0.30	0.40	0.009	0.012	0.016	
С	0.15	0.20	0.25	0.006	0.008	0.010	
D		3.30 BSC		0.130 BSC			
D1	2.95	3.05	3.15	0.116	0.120	0.124	
D2	1.98	2.11	2.24	0.078	0.083	0.088	
E		3.30 BSC		0.130 BSC			
E1	2.95	3.05	3.15	0.116	0.120	0.124	
E2	1.47	1.60	1.73	0.058	0.063	0.068	
E3	0.23	0.30	0.40	0.009	0.012	0.016	
е		0.65 BSC		(	0.026 BS	2	
G	0.30	0.41	0.51	0.012	0.016	0.020	
K	0.65	0.80	0.95	0.026	0.032	0.037	
L	0.30	0.43	0.56	0.012	0.017	0.022	
L1	0.06	0.13	0.20	0.002	0.005	0.008	
M	1.40	1.50	1.60	0.055	0.059	0.063	
θ	0 °		12 °	0 °		12 °	





DIMENSION: MILLIMETERS

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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